

# Search Notes



Application No.

10/068,713

Examiner

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Applicant(s)

TAKAHASHI ET AL.

Art Unit

1745

## SEARCHED

Class	Subclass	Date	Examiner
429	171	2/20/2004	<i>[Signature]</i>
	174		
	167		
	173		

*above to date 9/13/04*

*above to date 3/10/05*

*above to date 1/8/06*

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST keyword search Inventor search via PALM link, searched via EAST, eDAN	2/20/2004	<i>[Signature]</i>